Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/552,311	OONK ET AL.	
Examiner	Art Unit	
Ngoc-Yen M. Nguyen	1754	

SEARCHED							
Class	Subclass	Date	Examiner				
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INTERFERENCE SEARCHED						
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
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